

**General Description:**

CS70N06 A4, the silicon N-channel Enhanced VDMOSFETs, is obtained by the high density Trench technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. This device is suitable for use as a load switch and PWM applications. The package form is TO-252, which accords with the RoHS standard.

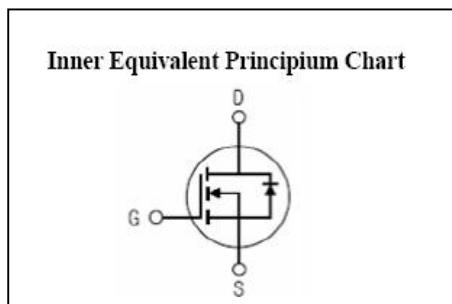
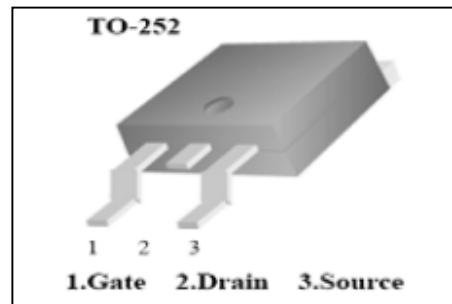
Features:

- | **Fast Switching**
- | **Low ON Resistance**($R_{DS(on)} \leq 10 \text{ m}\Omega$)
- | **Low Gate Charge**
- | **Low Reverse transfer capacitances**
- | **100% Single Pulse avalanche energy Test**

Applications:

Power switch circuit of adaptor and charger.

V_{DSS}	60	V
I_D	70	A
P_D	113	W
$R_{DS(ON)Typ}$	7.2	$\text{m}\Omega$



Absolute ($T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Rating	Units
V_{DSS}	Drain-to-Source Voltage	60	V
I_D	Continuous Drain Current	70	A
	Continuous Drain Current $T_c = 100^\circ\text{C}$	57	A
I_{DM}^{a1}	Pulsed Drain Current	280	A
V_{GS}	Gate-to-Source Voltage	± 20	V
E_{AS}^{a2}	Avalanche Energy	230	mJ
I_{AS}^{a2}	Avalanche Current	30.4	A
P_D	Power Dissipation	113	W
	Derating Factor above 25°C	0.904	$\text{W}/^\circ\text{C}$
T_J, T_{stg}	Operating Junction and Storage Temperature Range	150, -55 to 150	$^\circ\text{C}$

**Electrical Characteristics** ($T_C = 25^\circ C$ unless otherwise specified):

OFF Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
V_{DSS}	Drain to Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	60	--	--	V
I_{DSS}	Drain to Source Leakage Current	$V_{DS} = 60V, V_{GS} = 0V, T_a = 25^\circ C$	--	--	1	μA
		$V_{DS} = 48V, V_{GS} = 0V, T_a = 125^\circ C$	--	--	100	
$I_{GSS(F)}$	Gate to Source Forward Leakage	$V_{GS}=20V$	--	--	100	nA
$I_{GSS(R)}$	Gate to Source Reverse Leakage	$V_{GS}=-20V$	--	--	-100	nA

ON Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$R_{DS(ON)}$	Drain-to-Source On-Resistance	$V_{GS}=10V, I_D=19A$	--	7.2	10	mΩ
$R_{DS(ON)}$	Drain-to-Source On-Resistance	$V_{GS}=4.5V, I_D=19A$	--	8.5	13	mΩ
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu A$	1.0	1.5	2.0	V
Pulse width $t_p \leq 300\mu s, \delta \leq 2\%$						

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
R_g	Gate resistance	$V_{GS}=0V, V_{DS}=0V, f=1MHz$	--	1.90	--	Ω
C_{iss}	Input Capacitance	$V_{GS} = 0V, V_{DS} = 30V, f = 1.0MHz$	--	3219	--	pF
C_{oss}	Output Capacitance		--	219.3	--	
C_{rss}	Reverse Transfer Capacitance		--	193.7	--	

Resistive Switching Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$t_{d(ON)}$	Turn-on Delay Time	$V_{GS}=10V, R_G=3\Omega, V_{DD}=30V, I_D=13.6A$	--	16.1	--	ns
t_r	Rise Time		--	23.4	--	
$t_{d(OFF)}$	Turn-Off Delay Time		--	71.6	--	
t_f	Fall Time		--	15.8	--	
$Q_g(4.5V)$	Total Gate Charge	$V_{GS}=10V, V_{DS}=30V, I_D=19A$	--	35.2	--	nC
$Q_g(10V)$	Total Gate Charge		--	69.9	--	
Q_{gs}	Gate to Source Charge		--	7.8	--	
Q_{gd}	Gate to Drain ("Miller") Charge		--	17.6	--	

**Source-Drain Diode Characteristics**

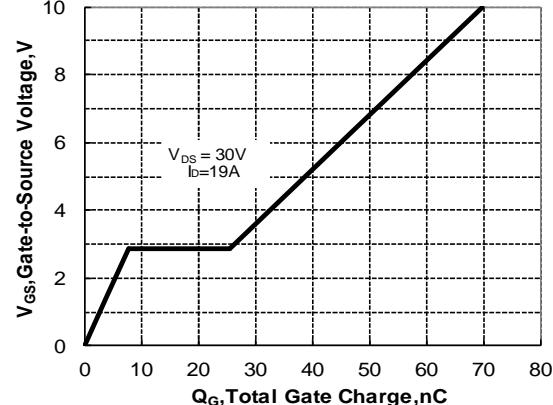
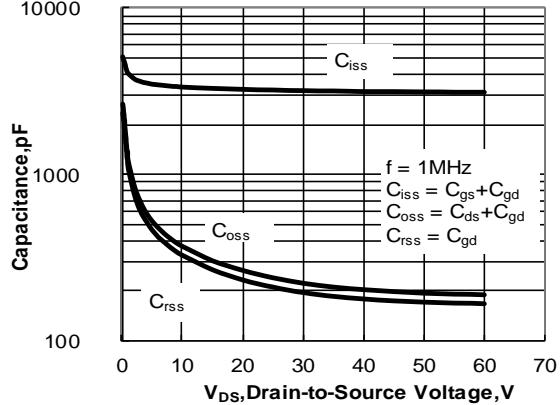
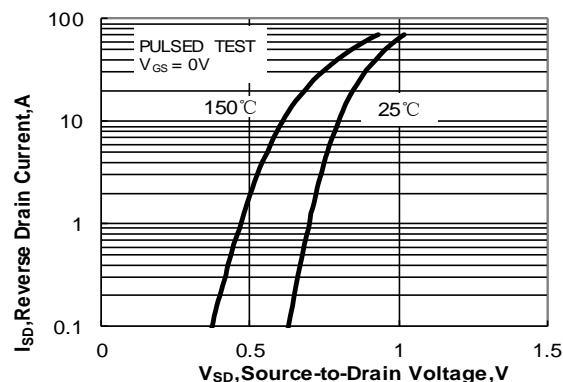
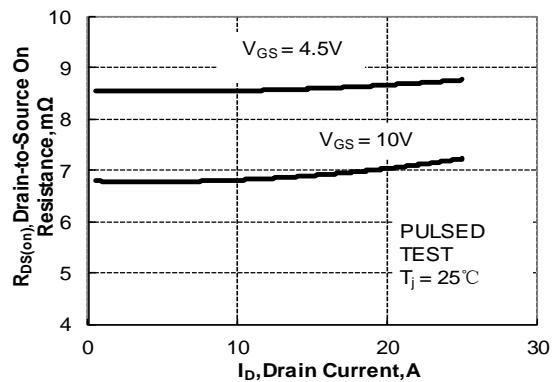
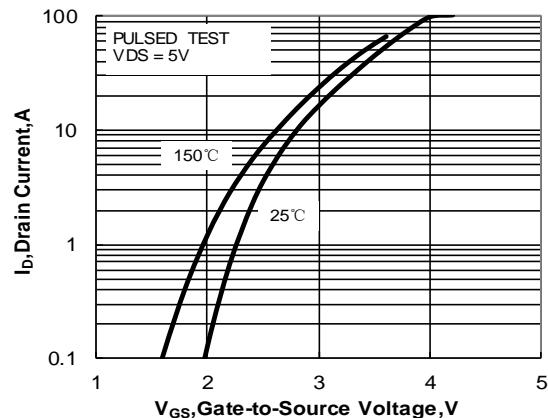
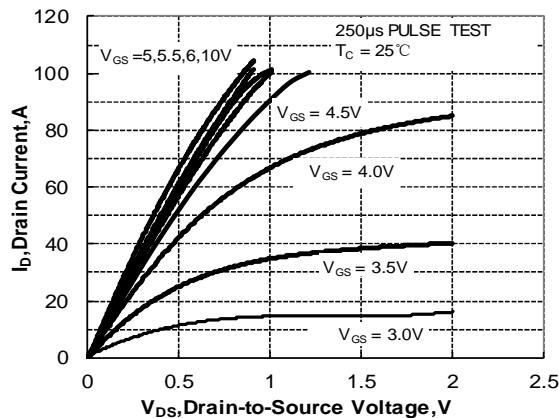
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
I _S	Continuous Source Current (Body Diode)		--	--	70	A
I _{SM}	Maximum Pulsed Current (Body Diode)		--	--	280	A
V _{SD}	Diode Forward Voltage	I _S =19A, V _{GS} =0V	--	--	1.5	V
trr	Reverse Recovery Time	di/dt=100A/us IF=19A	--	22.1	--	ns
Qrr	Reverse Recovery Charge		--	18.2	--	nC

Pulse width tp≤300μs, δ≤2%

Symbol	Parameter	Max.	Units
R _{θJC}	Junction-to-Csae	1.1	°C/W
R _{θJA}	Junction-to-Ambient	100	°C/W

^{a1}: Repetitive rating; pulse width limited by maximum junction temperature^{a2}: L=0.5mH, I_D=30.4A, Start T_j=25°C^{a3}: Recommend soldering temperature defined by IPC/JEDEC J-STD 020

Characteristics Curve:



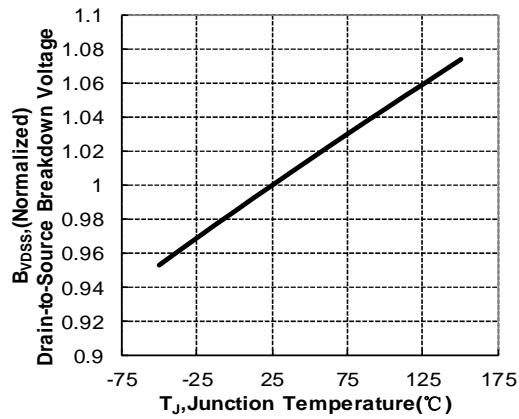


Figure 7. Normalized Breakdown Voltage vs Junction Temperature

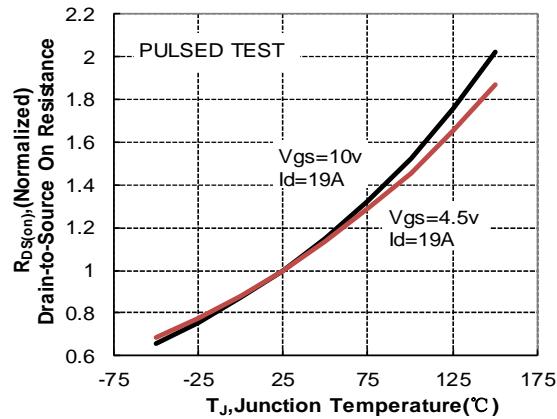


Figure 8. Normalized On Resistance vs Junction Temperature

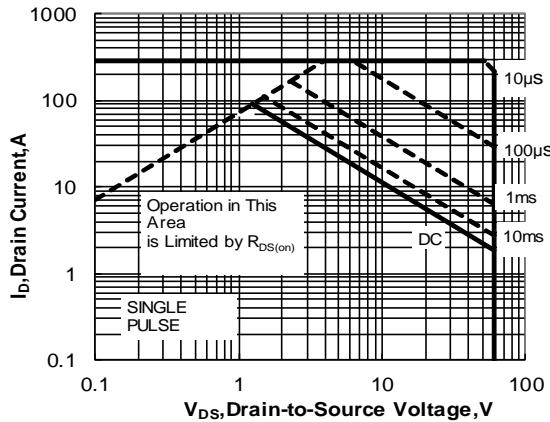


Figure 9. Maximum Safe Operating

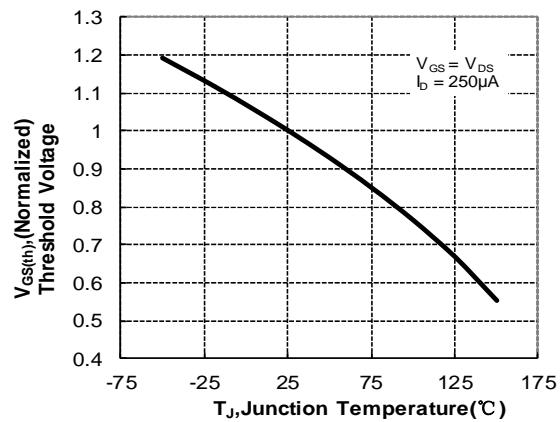


Figure 10. Normalized Threshold Voltage vs Junction Temperature

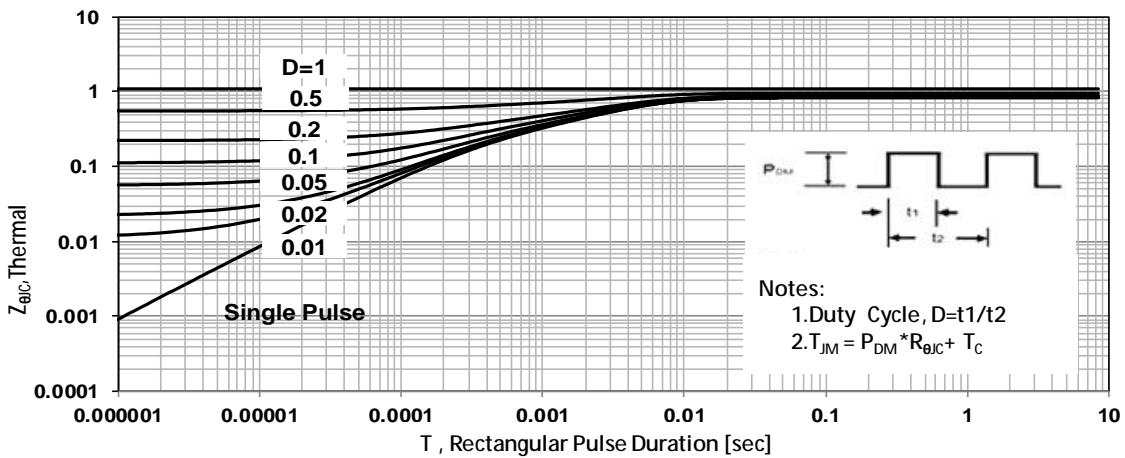


Figure 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

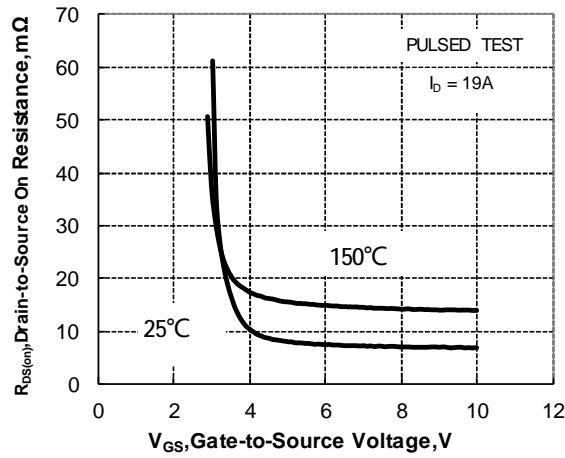


Figure 12. Drain-to-Source On Resistance vs Gate Voltage and Drain Current

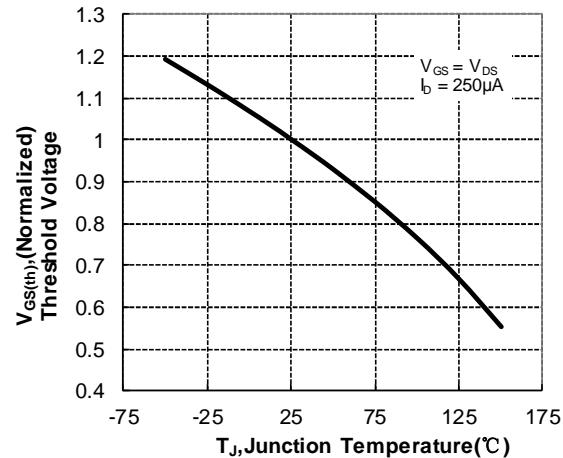


Figure 13. Normalized Threshold Voltage vs Junction Temperature

Test Circuit and Waveform

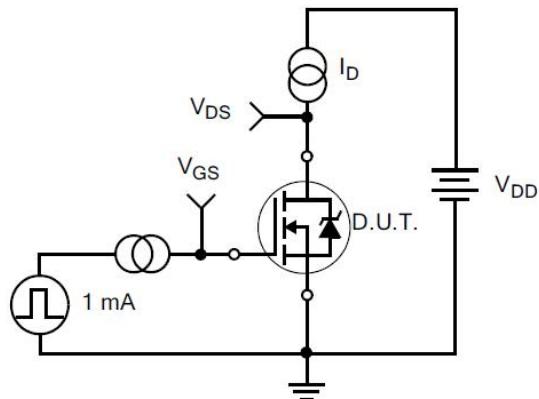


Figure 14. Gate Charge Test Circuit



Figure 15. Gate Charge Waveforms

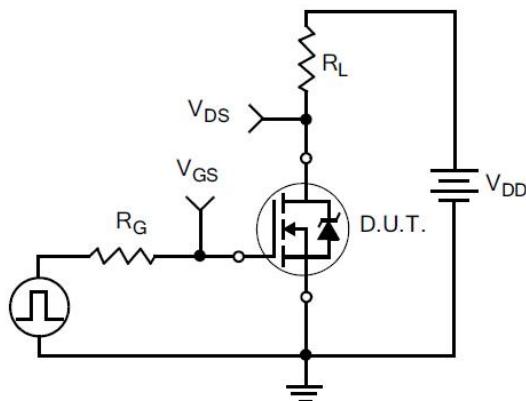


Figure 16. Resistive Switching Test Circuit



Figure 17. Resistive Switching Waveforms

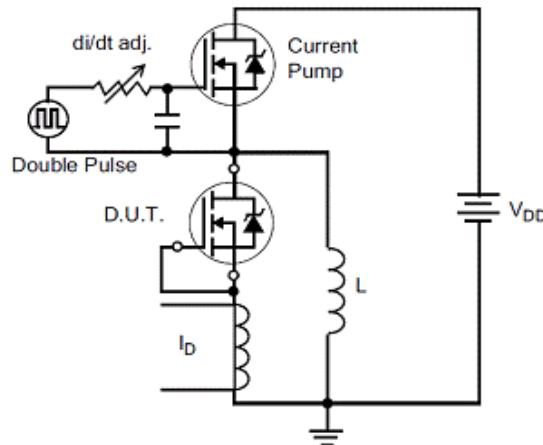


Figure 18. Diode Reverse Recovery Test Circuit



Figure 19. Diode Reverse Recovery Waveform



Figure 20. Unclamped Inductive Switching Test Circuit

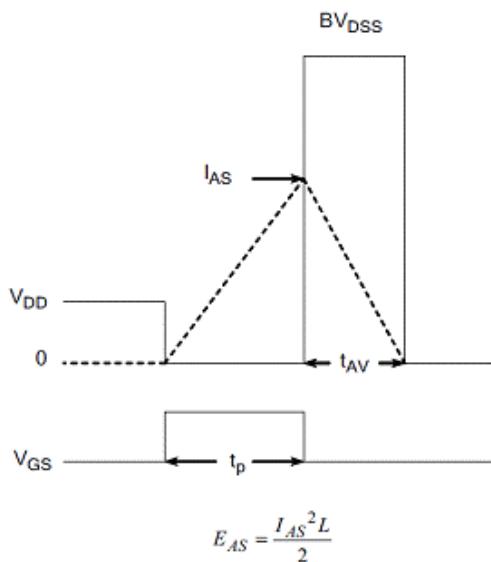
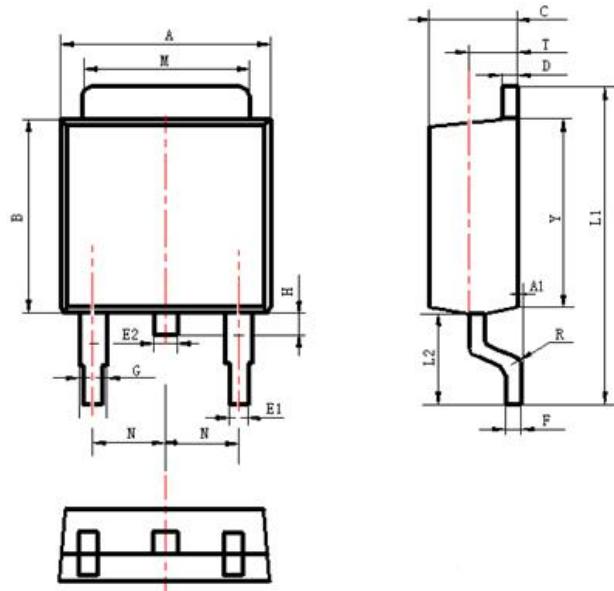


Figure 21. Unclamped Inductive Switching Waveform

Package Information:

Items	Values(mm)	
	MIN	MAX
A	6.30	6.90
A1	0	0.16
B	5.70	6.30
C	2.10	2.50
D	0.30	0.70
E1	0.60	0.90
E2	0.70	1.00
F	0.30	0.60
G	0.70	1.20
L1	9.60	10.50
L2	2.70	3.10
H	0.40	1.00
M	5.10	5.50
N	2.09	2.49
R	0.3	
T	1.40	1.60
Y	5.10	6.30

TO-252 Package



The name and content of poisonous and harmful material in products

Warnings

1. Exceeding the maximum ratings of the device in performance may cause damage to the device, even the permanent failure, which may affect the dependability of the machine. It is suggested to be used under 80 percent of the maximum ratings of the device.
 2. When installing the heat sink, please pay attention to the torsional moment and the smoothness of the heat sink.
 3. VDMOSFETs is the device which is sensitive to the static electricity, it is necessary to protect the device from being damaged by the static electricity when using it.
 4. This publication is made by Huajing Microelectronics and subject to regular change without notice.

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